Notice of References Cited Application/Control No. 10/676,820 Examiner JOHN Wahnkyo LEE Applicant(s)/Patent Under Reexamination STEINBERG ET AL. Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	Α	US-5,216,504 A	06-1993	Webb et al.	348/190
*	В	US-6,002,436 A	12-1999	Anderson, Eric C.	348/372
*	С	US-2001/0039804 A1	11-2001	Newman et al.	62/66
*	D	US-2003/0036860 A1	02-2003	Rice et al.	702/57
*	Е	US-2003/0174902 A1	09-2003	Barkan, Stanley	382/274
	F	US-			
	O	US-			
	Ι	US-			
	_	US-			
	٦	US-			
	K	US-			
	┙	US-			
	М	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	Ν	03/019473	03-2003	wo	Robins et al.	G06T 5/20
	0					
	Р					
	Ø					
	R					
	s					
	Т					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	٧	
	W	
	×	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).) Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.